•	Searcn	Notes	

Application/Control No.	Applicant(s)/Patent und Reexamination	er
10/717,503	YUDASAKA ET AL.	
Examiner	Art Unit	
Tuan Quach	2826	

Tuan Quach

	SEARCHED			
Class	Subclass	Date	Examiner	
257	57, 59, 347, 352, 353, 354	4/2/2005	TQ	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
		,	

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
EAST (USPAT; USPGPUB; DERWENT; EPO; JPO; IBDTDB)	4/2/2005	TQ
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